Application/Control No. Applicant(s)/Patent Under Reexamination 10/652,653 TANAKA ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2827 Viet Q. Nguyen **U.S. PATENT DOCUMENTS** Date **Document Number** Classification Name Country Code-Number-Kind Code MM-YYYY 711/114 US-2005/0210191 09-2005 Kobayashi et al. Α 714/006 Tomita, Aki US-2005/0086558 04-2005 В 714/006 US-2005/0076263 04-2005 Tomita, Aki С 709/213 08-2000 Brandt et al. US-6,101,533 D 709/213 US-6,009,463 12-1999 Brandt et al. Ε US-F US-Ğ SU Н us-1 US-J US-Κ US-US-М FOREIGN PATENT DOCUMENTS Document Number Date Name Classification Country Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s Т NON-PATENT DOCUMENTS Include as applicable: Author, Title Date, Rublisher, Edition or Volume, Pertinent Pages) U W

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